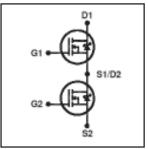


IRFI4020H-117P

Features

- Integrated half-bridge package
- · Reduces the part count by half
- Facilitates better PCB layout
- Key parameters optimized for Class-D audio amplifier applications
- Low R_{DS(ON)} for improved efficiency
- Low Qg and Qsw for better THD and improved efficiency
- Low Qrr for better THD and lower EMI
- Can delivery up to 300W per channel into 8Ω load in half-bridge configuration amplifier
- · Lead-free package

Key Parameters ®							
V _{DS} 200 V							
R _{DS(ON)} typ. @ 10V	80	mΩ					
Q _g typ.	19	nC					
Q _{sw} typ.	6.8	nC					
R _{G(int)} typ.	3.0	Ω					
T _J max	150	°C					





G1, G2	D1, D2	S1, S2
Gate	Drain	Source

Description

This Digital Audio MosFET Half-Bridge is specifically designed for Class D audio amplifier applications. It consists of two power MosFET switches connected in half-bridge configuration. The latest process is used to achieve low on-resistance per silicon area. Furthermore, Gate charge, body-diode reverse recovery, and internal Gate resistance are optimized to improve key Class D audio amplifier performance factors such as efficiency, THD and EMI. These combine to make this Half-Bridge a highly efficient, robust and reliable device for Class D audio amplifier applications.

Absolute Maximum Ratings ⑤

Drain-to-Source Voltage		
	200	V
Gate-to-Source Voltage	±20	
Continuous Drain Current, V _{GS} @ 10V	9.1	А
Continuous Drain Current, V _{GS} @ 10V	5.7	
Pulsed Drain Current ①	36	
Power Dissipation ®	21	W
Power Dissipation ®	8.5	
Linear Derating Factor	0.17	W/°C
Single Pulse Avalanche Energy②	130	mJ
Operating Junction and	-55 to + 150	°C
Storage Temperature Range		
Soldering Temperature, for 10 seconds	200	
(1.6mm from case)	300	
Mounting torque, 6-32 or M3 screw	10lb·in (1.1N·m)	
	Continuous Drain Current, V _{GS} @ 10V Continuous Drain Current, V _{GS} @ 10V Pulsed Drain Current ① Power Dissipation ④ Power Dissipation ④ Linear Derating Factor Single Pulse Avalanche Energy② Operating Junction and Storage Temperature Range Soldering Temperature, for 10 seconds (1.6mm from case)	Continuous Drain Current, $V_{GS} @ 10V$ 9.1 Continuous Drain Current, $V_{GS} @ 10V$ 5.7 Pulsed Drain Current ① 36 Power Dissipation ④ 21 Power Dissipation ④ 8.5 Linear Derating Factor 0.17 Single Pulse Avalanche Energy② 130 Operating Junction and -55 to + 150 Storage Temperature Range Soldering Temperature, for 10 seconds (1.6mm from case)

Thermal Resistance ^⑤

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ④		5.9	°C/W
$R_{\theta JA}$	Junction-to-Ambient (free air)		65	

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Electrical Characteristics @ T_J = 25°C (unless otherwise specified) ©

	Parameter	Min.	Тур.	Max.	Units	Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	200			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		24		mV/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		80	100	mΩ	$V_{GS} = 10V, I_D = 5.5A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	3.0		4.9	V	$V_{DS} = V_{GS}$, $I_D = 100\mu A$
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Coefficient		-12		mV/°C	
I _{DSS}	Drain-to-Source Leakage Current			20	μA	$V_{DS} = 200V, V_{GS} = 0V$
				250		$V_{DS} = 200V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100	Ī	$V_{GS} = -20V$
9 _{fs}	Forward Transconductance	11			S	$V_{DS} = 50V, I_{D} = 5.5A$
Q_g	Total Gate Charge		19	29		
Q _{gs1}	Pre-Vth Gate-to-Source Charge		4.9		1	V _{DS} = 100V
Q _{gs2}	Post-Vth Gate-to-Source Charge		0.95		nC	$V_{GS} = 10V$
Q_gd	Gate-to-Drain Charge		5.8			I _D = 5.5A
Q_{godr}	Gate Charge Overdrive		7.4			See Fig. 6 and 15
Q_{sw}	Switch Charge (Q _{gs2} + Q _{gd})		6.8			
$R_{G(int)}$	Internal Gate Resistance		3.0		Ω	
t _{d(on)}	Turn-On Delay Time		8.4			V _{DD} = 100V, V _{GS} = 10V ③
t _r	Rise Time		8.0		1	$I_D = 5.5A$
t _{d(off)}	Turn-Off Delay Time		18		ns	$R_G = 2.4\Omega$
t _f	Fall Time		4.0			
C _{iss}	Input Capacitance		1240			$V_{GS} = 0V$
C _{oss}	Output Capacitance		130		pF	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		28		1	f = 1.0MHz, See Fig.5
C _{oss} eff.	Effective Output Capacitance		110		1	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 160V$
L _D	Internal Drain Inductance		4.5			Between lead, p
					nΗ	6mm (0.25in.)
L _S	Internal Source Inductance		7.5			from package
						and center of die contact

Diode Characteristics ⑤

	Parameter	Min.	Тур.	Max.	Units	Conditions
$I_S @ T_C = 25^{\circ}C$	Continuous Source Current			9.1		MOSFET symbol
	(Body Diode)				Α	showing the
I _{SM}	Pulsed Source Current			36		integral reverse
	(Body Diode) ①					p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 5.5A, V_{GS} = 0V$ ③
t _{rr}	Reverse Recovery Time		76	110	ns	$T_J = 25$ °C, $I_F = 5.5$ A, $V_{DD} = 160$ V
Q _{rr}	Reverse Recovery Charge		230	350	nC	di/dt = 100A/µs ③

Notes:

① Repetitive rating; pulse width limited by max. junction temperature.

② Starting $T_J = 25$ °C, L = 8.6mH, $R_G = 25\Omega$, $I_{AS} = 5.5$ A.

③ Pulse width \leq 400 μ s; duty cycle \leq 2%.

 $\ \, \mbox{\it \ } \mbox{\it \ }$

⑤ Specifications refer to single MosFET.

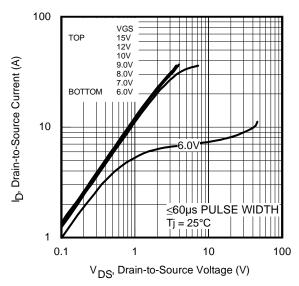
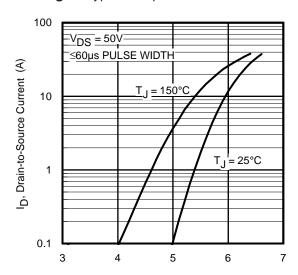


Fig 1. Typical Output Characteristics



V_{GS}, Gate-to-Source Voltage (V) **Fig 3.** Typical Transfer Characteristics

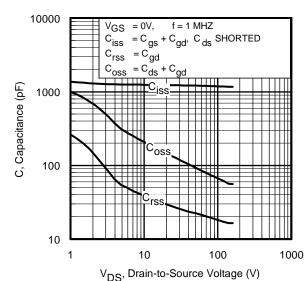


Fig 5. Typical Capacitance vs.Drain-to-Source Voltage www.irf.com

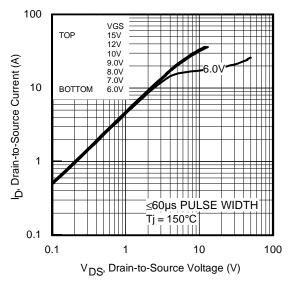


Fig 2. Typical Output Characteristics

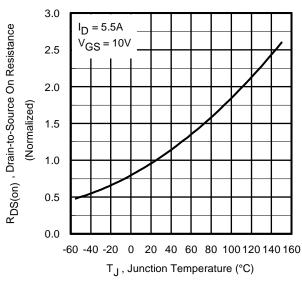


Fig 4. Normalized On-Resistance vs. Temperature

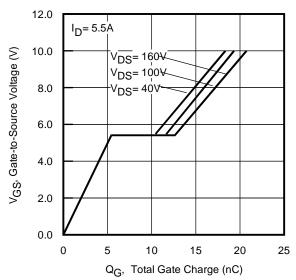


Fig 6. Typical Gate Charge vs.Gate-to-Source Voltage

IRFI4020H-117P

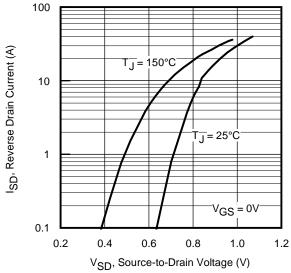


Fig 7. Typical Source-Drain Diode Forward Voltage

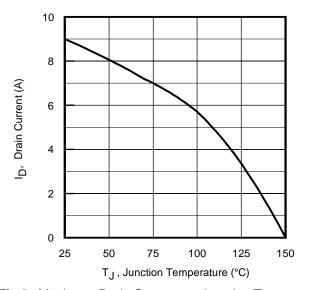


Fig 9. Maximum Drain Current vs. Junction Temperature

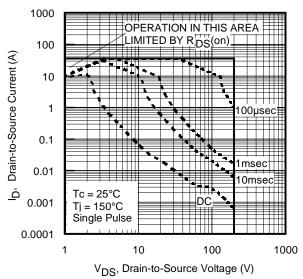


Fig 8. Maximum Safe Operating Area

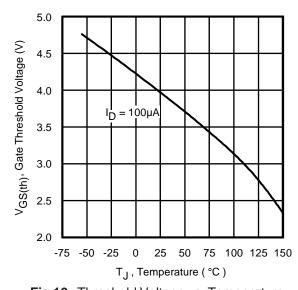


Fig 10. Threshold Voltage vs. Temperature

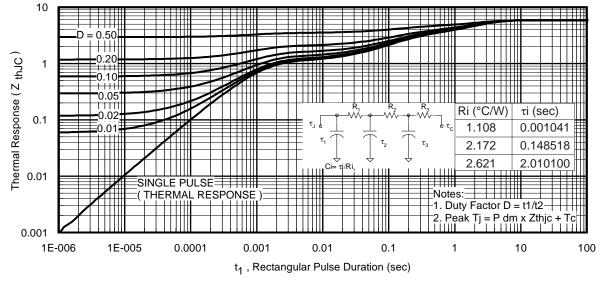


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

IRFI4020H-117P

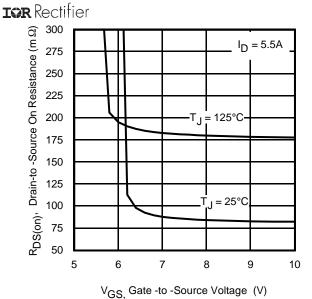


Fig 12. On-Resistance vs. Gate Voltage

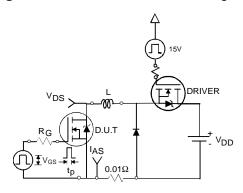


Fig 13b. Unclamped Inductive Test Circuit

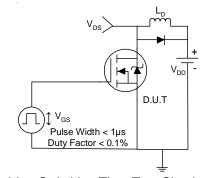


Fig 14a. Switching Time Test Circuit

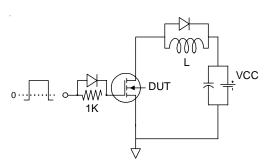


Fig 15a. Gate Charge Test Circuit www.irf.com

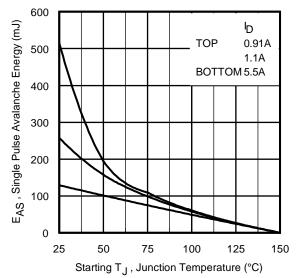


Fig 13a. Maximum Avalanche Energy vs. Drain Current

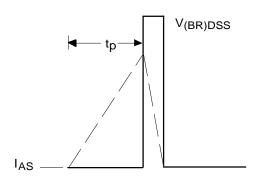


Fig 13c. Unclamped Inductive Waveforms

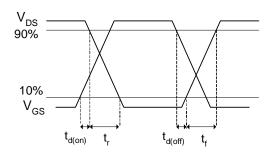


Fig 14b. Switching Time Waveforms

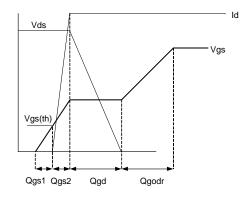
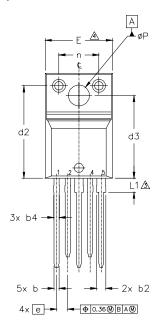
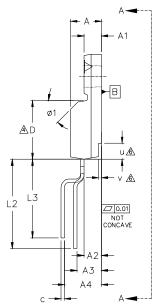


Fig 15b Gate Charge Waveform

TO-220 Full-Pak 5-Pin Package Outline, Lead-Form Option 117

(Dimensions are shown in millimeters (inches))





	A =	A →	
<u> </u>		 ►-B	
#D #1		 u_&	
L3		V &	
	A2 A3	-	

- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994
- DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE, THESE DIMENSIONS ARE MEASURED AT THE OUTER MOST EXTREMES OF THE PLASTIC BODY.
- DIMENSION 61, 63, 65 & c1 APPLY TO BASE METAL ONLY.
- STEP OPTIONAL ON PLASTIC BODY DEFINED BY DIMENSIONS u & v.
- CONTROLLING DIMENSION: INCHES.

S						
М	DIMENSIONS					
l B	MILLIM	ETERS	INCHES		N O T E S	
, O	MIN.	MAX.	MIN.	MAX.	5	
Α	4.57	4.83	.180	.190		
A1	2.57	2.83	.101	.111		
A2	2.51	2.85	.099	.112		
A3	3.73	4.24	.147	.167		
A4	5.79	6,29	.228	.248		
b	0.61	0.95	0.24	.037		
ь1	0.56	0.90	.022	0.35	5	
b2	1.13	1.48	0.44	.058		
b3	1.08	1,43	0.42	.056	5	
b4	0.76	1.06	.030	.042		
b5	0.71	1.01	.028	.040	5	
c	0.33	0.63	.013	.025		
c1	0.28	0.58	.011	.023	5	
D	8.65	9.80	.341	.386	4	
d1	15.80	16.12	.622	.635		
d2	13,97	14,22	.550	.560		
d3	12.30	12.92	.484	.509		
E	9.63	10.63	.379	.419	4	

S Y M	DIMENSIONS				Ŋ
В	MILLIM	ETERS	INC	HES	NO TES
O L	MIN.	MAX.	MIN,	MAX,	5
е	1,70	BSC	.067	BSC	
L	13.20	13.73	.520	.541	1
L1	1,91	2,31	.075	,091	3
L2	12.7	13,46	.500	.530	
L3	10.92	11.68	.430	.460	
n	6.05	6.15	.238	.242	
øΡ	3.05	3,45	.120	.136	
u	2.40	2.50	.094	.098	6
v	0.40	0.50	.016	.020	6
ø1	-	45'	-	45*	

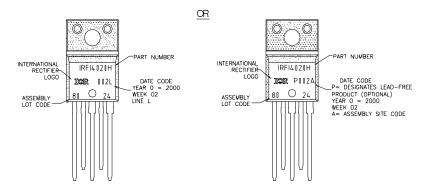
LEAD ASSIGNMENTS

- 1 SOURCE 2 2 - GATE 2
- 3 DRAIN 2 / SOURCE 1
- 4 GATE 1
- 5 DRAIN 1

TO-220 Full-Pak 5-Pin Part Marking Information

EXAMPLE: THIS IS AN IRFI4020H WITH LOT CODE 8024 ASSEMBLED ON WW02,2000 IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line position indicates "Lead Free"



TO-220AB Full-Pak 5-Pin package is not recommended for Surface Mount Application.

Data and specifications subject to change without notice. This product has been designed for the Consumer market. Qualification Standards can be found on IR's Web site.



IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105

TAC Fax: (310) 252-7903

Note: For the most current drawings please refer to the IR website at: http://www.irf.com/package/

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